

Features

- 1206 1.0mm SMD LED
- High Brightness
- AllnGaP / InGaN Technology
- Side View
- High reliability
- Clear Lens

Applications

- Consumer Electronics
- Wearables
- Automobile After Market
- Industrial Equipment

Description

The IN-S126TASRGB is a popular 1206 side view RGB package with versatile design capabilities. It is a PCB type molding style LED which can be used in various applications.

Recommended Solder Pattern

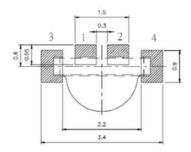
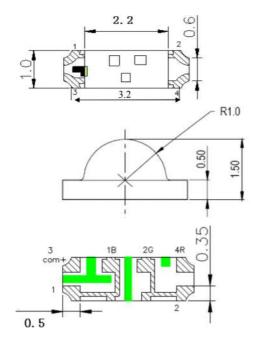
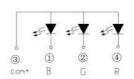


Figure 1. IN-S126TASRGB Solder Pattern

Package Dimensions in mm





Notes.

- 1. All dimensions are in millimeters.
- 2. Tolerance is ± 0.1 mm unless otherwise noted

Figure 2. IN-S126TASRGB Package Dimensions



Absolute Maximum Rating at 25°C (Note 1)

Product	Emission Color	P _d (mW)	I _F (mA)	I _{FP} * (mA)	V _R (V)	T _{OP} (°C)	T _{ST} (°C)
	Red	75	25	70			
IN-S126TASRGB	Blue	75	25	100	5	-30~+85	-40~+90
	Green	75		100			

Notes

1. Condition for IFP is pulse of 1/10 duty and 0.1msec width

ESD Precaution

ATTENTION: Electrostatic Discharge (ESD) protection



The symbol above denotes that ESD precaution is needed. ESD protection for GaP and AlGaAs based chips is necessary even though they are relatively safe in the presence of low static-electric discharge. Parts built with AllnGaP, GaN, or/and InGaN based chips are STATIC SENSITIVE devices. ESD precaution must be taken during design and assembly.

If manual work or processing is needed, please ensure the device is adequately protected from ESD during the process.

Please be advised that normal static precautions should be taken in the handling and assembly of this device to prevent damage or degradation which may be induced by electrostatic discharge (ESD).

Electrical Characteristics $T_A = 25\%$ (Note 1)

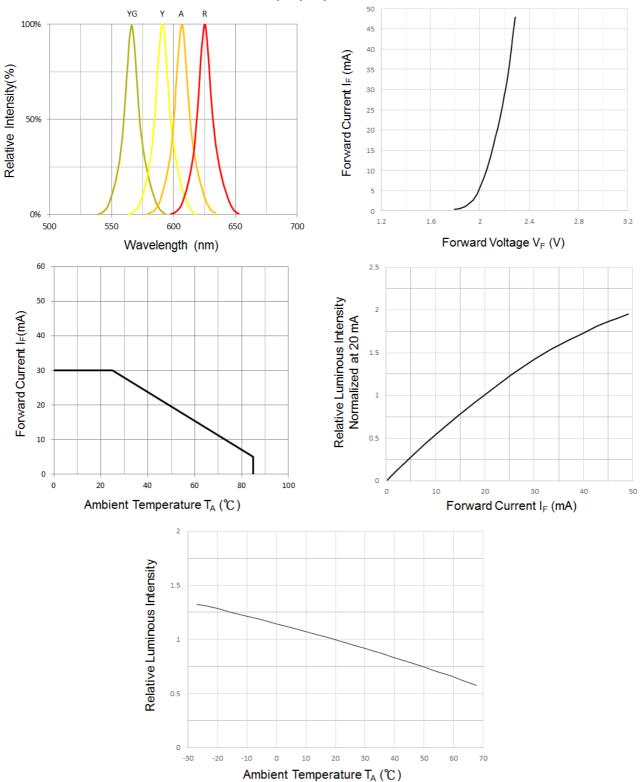
Product	Emission	I _F	V _F (V)		λ(nm)			Viewing Angle	I* _V (mcd)		
	Color	(mA)	typ.	max	λ_{D}	$\lambda_{ extsf{P}}$	Δλ	2 <i>θ</i> 1/2	Min.	typ.	Max
IN-S126TASRGB	Red	20	1.6	2.6	615~630	625	20	120	150	250	350
	Green	20	2.8	3.6	515~530	523	35	120	700	1100	1500
	Blue	20	2.8	3.6	461~470	470	30	120	150	200	300

Notes

1. Performance guaranteed only under conditions listed in above tables.

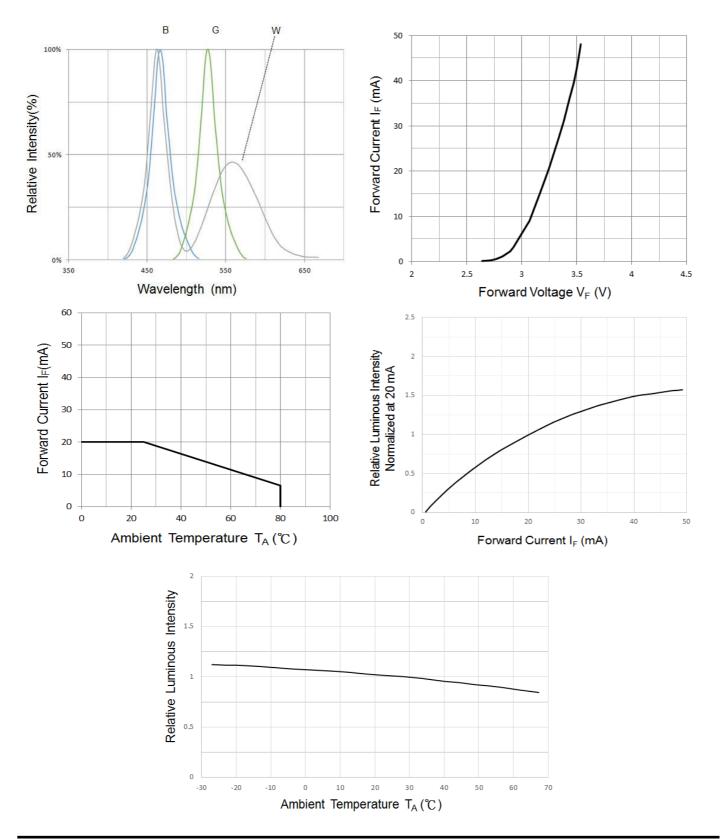


Typical Characteristic Curves - YG, Y, A, R



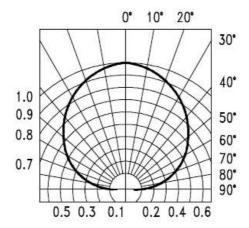


Typical Characteristic Curves - B, G, W





Typical Characteristic Curves – Radiation Pattern

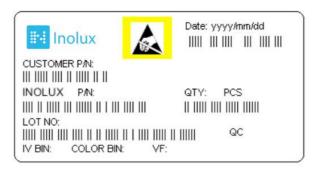


Ordering Information

Product	Emission Color	Technology	Test Current I _F (mA)	Luminous Intensity Iv (mcd) (Typ.)	Forward Voltage V _F (V) (Typ.)	Orderable Part Number
	Red	AllnGaP	20	250	2.0	
IN-S126TASRGB	Green	InGaN	20	1100	3.2	IN-S126TASRGB
	Blue	InGaN	20	200	3.2	



Label Specifications



Inolux P/N:

I	N	-	S	1	2	6	Т	Α	S			R	G	В	-	-	-	-	-
			Material	F	Package	e	Vari	ation	Orientation	Current	Lens		Color				ustor Stam		
	olux //D		S = PCB Type	126	TA = 3. T	2 x 1.5 ri-Chip		mm	S = Side View	(Blank) = 20mA	(Blank) = Clear	G	=625n =523n =470n	m			-		

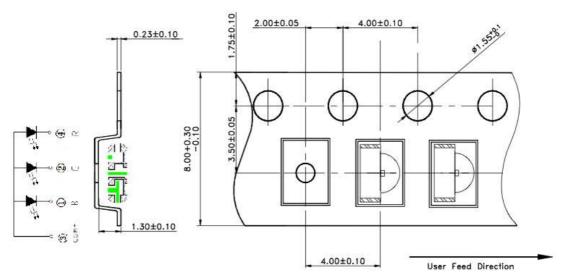
Lot No.:

Z	2	0	1	7	01	24	001
Internal		Year (2017	2010 \	Month	Date	Serial	
Tracker		Teal (2017)	, 2010,)	WIGHT	Date	Serial	



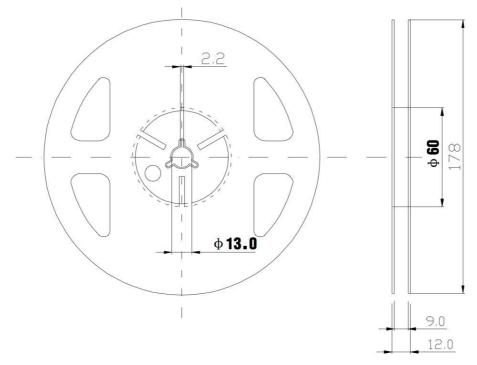
Packaging Information: 3000pcs Per Reel

Tape Dimension



Unit: mm Tolerance: +/-0.10 mm

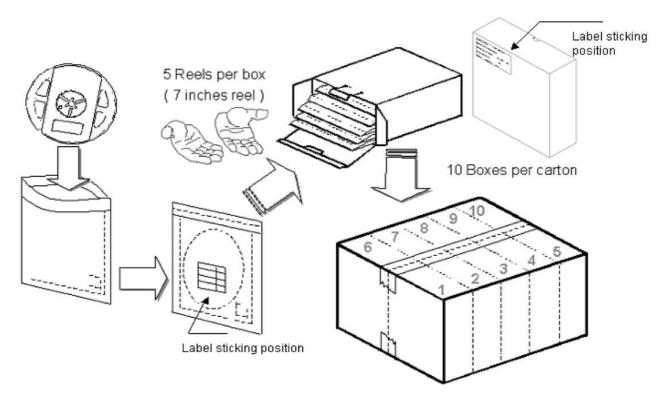
Reel Dimension



Unit: mm Tolerance: +/-0.15mm



Packing Dimension



5 boxes per carton are available depending on shipment quantity.

	Specification	Material	Quantity
Carrier tape	Per EIA 481-1A specs	Conductive black tape	3000pcs per reel
Reel	Per EIA 481-1A specs	Conductive black	
Label	IN standard	Paper	
Packing bag	220x240mm	Aluminum laminated bag/ no-zipper	One reel per bag
Carton	IN standard	Paper	Non-specified
Othors	<u> </u>		

Others:
Each immediate box consists of 5 reels. The 5 reels may not necessarily have the same lot number or the same bin combinations of Iv, λ_D and Vf. Each reel has a label identifying its specification; the immediate box consists of a product label as well.

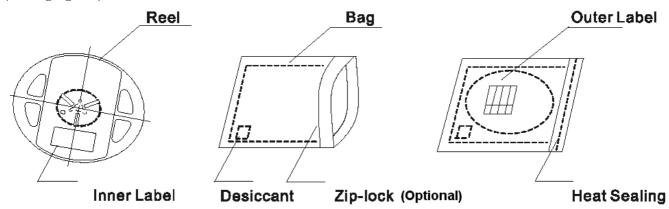


Dry Pack

All SMD optical devices are **MOISTURE SENSITIVE**. Avoid exposure to moisture at all times during transportation or storage. Every reel is packaged in a moisture protected anti-static bag. Each bag is properly sealed prior to shipment.

Upon request, a humidity indicator will be included in the moisture protected anti-static bag prior to shipment.

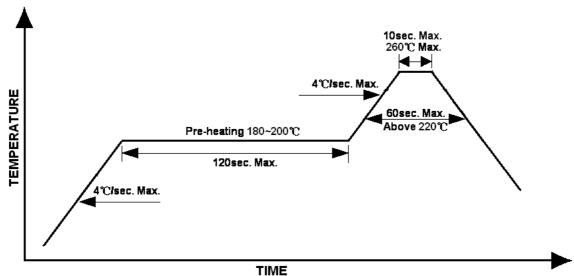
The packaging sequence is as follows:



Reflow Soldering

- Recommended tin glue specifications: melting temperature in the range of 178~192 °C
- The recommended reflow soldering profile is as follows (temperatures indicated are as measured on the surface of the LED resin):

Lead-free Solder Profile



IN-S126TASRGB Side View SMD LED 1206 PCB Type

Precautions

- Avoid exposure to moisture at all times during transportation or storage.
- Anti-Static precaution must be taken when handling GaN, InGaN, and AllnGaP products.
- It is suggested to connect the unit with a current limiting resistor of the proper size. Avoid applying a reverse voltage.
- Avoid operation beyond the limits as specified by the absolute maximum ratings.
- Avoid direct contact with the surface through which the LED emits light.
- If possible, assemble the unit in a clean room or dust-free environment.

Reworking

- Rework should be completed within 5 seconds under 260 °C.
- The iron tip must not come in contact with the copper foil.
- Twin-head type is preferred.

Cleaning

Following are cleaning procedures after soldering:

- An alcohol-based solvent such as isopropyl alcohol (IPA) is recommended.
- Temperature x Time should be 50°C x 30sec. or <30°C x 3min
- Ultra sonic cleaning: < 15W/ bath; bath volume ≤ 1liter
- Curing: 100 °C max, <3min

Cautions of Pick and Place

- Avoid stress on the resin at elevated temperature.
- Avoid rubbing or scraping the resin by any object.
- Electro-static may cause damage to the component. Please ensure that the equipment is properly grounded. Use of an ionizer fan is recommended.



IN-S126TASRGB Side View SMD LED 1206 PCB Type

Reliability

failures Reference For all reliability Precondition Precondition For all reliability Monitoring tests according to JEDEC Level 2 To JEDEC Level 2 To JESD22-B102-B And CNS-5068 Reference 1.) Baking at 85°C for 24hrs 2.) Moisture storage at 85°C/60% R.H. for 168hrs Accelerated aging 155°C/24hrs Tinning speed: 2.5+0.5cm/s	liability			
Precondition For all reliability monitoring tests according to JEDEC Level 2 1.0 Baking at 85°C for 24hrs 2.1 Moisture storage at 85°C for 24hrs 2.2 Moisture storage at 85°C for 8.H. for 168hrs 2.3 Moisture storage at 85°C for 8.H. for 168hrs 3.50 Moisture storage at 85°C for 24hrs 4.50 Moisture storage	Item	Frequency/ lots/ samples/	Standards	Conditions
Precondition				4 \ Dall'ar at 0500 (a. 04)
To JEDEC Level 2 168hrs 1Q/ 1/ 22/ 0 JESD22-B102-B Accelerated aging 155°C/ 24hrs Tinning speed: 2.5+0.5cm/s Tinning: A: 215°C/ 3+1s or B: 260°C/ 10+1			J-S1D-020	
Solderability	Precondition			
Solderability And CNS-5068 Tinning speed: $2.5+0.5$ cm/s Tinning: A: 215° C/ $3+1s$ or B: 260° C/ $10+1$ CNS-5067 Dipping soldering terminal only Soldering bath temperature A: $260+/-5^{\circ}$ C; $10+/-1s$ B: $350+/-10^{\circ}$ C; $3+/-0.5s$ Operating life test 1Q/ 1/ 40/ 0 CNS-11829 1.) Precondition: 85° C baking for 24 hrs 85° C/ 60° R.H. for 168 hrs 2.) Tamb 25° C; IF= 20 mA; duration 1000 hrs High humidity, high temperature bias High temperature bias 1Q/ 1/ 20 IN specs. Tamb: 85° C Humidity: 85° R.H., IF= 5 mA Duration: 1000 hrs Tamb: 55° C IF= 20 mA Duration: 1000 hrs 1Q/ 1/ $40/$ 0 Pulse life test				
Tinning: \dot{A} : 215°C/ 3+1s or B: 260°C/ 10+1 CNS-5067 Dipping soldering terminal only Soldering bath temperature A: 260+/-5°C; 10+/-1s B: 350+/-10°C; 3+/-0.5s IQ/ 1/ 40/ 0 CNS-11829 1.) Precondition: 85°C baking for 24hrs 85°C/ 60%R.H. for 168hrs 2.) Tamb25°C; IF=20mA; duration 1000hrs High humidity, high temperature bias High temperature bias IQ/ 1/ 20 IN specs. IN specs. Tamb: 55°C IF=20mA, IP=100mA, Duty cycle=0.125 (tp=125 μ s,T=1sec)		1Q/ 1/ 22/ 0		Accelerated aging 155°C/ 24hrs
Resistance to soldering heat CNS-5067 Dipping soldering terminal only Soldering bath temperature A: $260+/-5^{\circ}$ C; $10+/-1s$ B: $350+/-10^{\circ}$ C; $3+/-0.5s$ Operating life test Operating life test IQ/ 1/ 40/ 0 CNS-11829 CNS-11829 1.) Precondition: 85° C baking for 24hrs 85° C/ 60° R.H. for 168hrs 2.) Tamb25°C; IF=20mA; duration 1000hrs High humidity, high temperature bias High temperature bias IQ/ 1/ 45/ 0 IN specs. In specs and specific test In specs and specific test and	Solderability		And CNS-5068	Tinning speed: 2.5+0.5cm/s
Resistance to soldering heat $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$				Tinning: A: 215°C/ 3+1s or B: 260°C/ 10+1s
soldering heat $\begin{array}{cccccccccccccccccccccccccccccccccccc$			CNS-5067	Dipping soldering terminal only
soldering heat $\begin{array}{cccccccccccccccccccccccccccccccccccc$	Resistance to			Soldering bath temperature
$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	soldering heat			
Operating life test $ \begin{array}{c} 1Q/\ 1/\ 40/\ 0 \\ \\ Operating life test \\ \end{array} \begin{array}{c} 1Q/\ 1/\ 40/\ 0 \\ \\ Operating life test \\ \end{array} \begin{array}{c} 1.) \ Precondition: 85^{\circ}C \ baking for 24hrs \\ 85^{\circ}C/\ 60^{\circ}R.H. \ for 168hrs \\ 2.) \ Tamb25^{\circ}C; \ IF=20mA; \ duration 1000hrs \\ \\ Tamb: 85^{\circ}C \\ \\ Humidity: 85^{\circ}R.H., \ IF=5mA \\ \\ Duration: 1000hrs \\ \end{array} \\ \begin{array}{c} 1Q/\ 1/\ 20 \\ \\ High \ temperature \ bias \\ \end{array} \begin{array}{c} 1Q/\ 1/\ 20 \\ \\ IN \ specs. \\ \end{array} \begin{array}{c} IN \ specs. \\ \\ IR=20mA \\ \\ Duration: 1000hrs \\ \end{array} \\ \begin{array}{c} 1Q/\ 1/\ 40/\ 0 \\ \\ Pulse \ life \ test \\ \end{array} \begin{array}{c} 1Q/\ 1/\ 40/\ 0 \\ \end{array} \begin{array}{c} IQ/\ 1/\ 40/\ 0 \\ \end{array} \begin{array}{c} IN \ specs. \\ \end{array} \begin{array}{c} IN \ specs. \\ \end{array} \begin{array}{c} IR=20mA, \ Ip=100mA, \ Duty \\ cycle=0.125 \ (tp=125\ \mu\ s, T=1sec) \\ \end{array}$				
Operating life test $ 85^{\circ}\text{C}/60\%\text{R.H. for } 168\text{hrs} \\ 2.) \text{ Tamb25}^{\circ}\text{C}; \text{ IF=20mA; duration } 1000\text{hrs} \\ \text{High humidity,} \\ \text{high temperature} \\ \text{bias} \\ \text{High temperature} \\ \text{bias} \\ \text{IN specs.} \\ \text{IN specs.} \\ \text{Tamb: } 85^{\circ}\text{C} \\ \text{Humidity: } 85^{\circ}\text{R.H., IF=5mA} \\ \text{Duration: } 1000\text{hrs} \\ \text{Tamb: } 55^{\circ}\text{C} \\ \text{IF=20mA} \\ \text{Duration: } 1000\text{hrs} \\ \text{IV specs.} \\ \text{Tamb25}^{\circ}\text{C}, \text{ If=20mA, Ip=100mA, Duty} \\ \text{Pulse life test} \\ \text{Pulse life test} \\ \text{IV specs.} \\ \text{Tamb25}^{\circ}\text{C}, \text{ If=20mA, Ip=100mA, Duty} \\ \text{Cycle=0.125 (tp=125 μ s,T=1sec)} \\ \text{Tamb25}^{\circ}\text{C}, \text{ If=215}^{\circ}\text{C}, \text{ If=215}^$		1Q/ 1/ 40/ 0	CNS-11829	
High humidity, high temperature bias $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Operating life test			
High humidity, high temperature bias $1Q/1/45/0$ JESD-A101-BTamb: 85°C Humidity: 85% R.H., IF=5mA Duration: 1000hrsHigh temperature bias $1Q/1/20$ IN specs.Tamb: 55°C IF=20mA Duration: 1000hrs1Q/ 1/ 40/ 0Tamb25°C, If=20mA,, Ip=100mA, Duty cycle=0.125 (tp=125 μ s,T=1sec)				
high temperature bias	High humidity	10/ 1/ 45/ 0	JESD-A101-B	
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High temperature bias $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$				
High temperature bias		10/1/20	IN space	
Duration: 1000hrs		1 47 17 20	ПУ эрсоз.	
1Q/ 1/ 40/ 0 Tamb25°C, If=20mA,, Ip=100mA, Duty cycle=0.125 (tp=125 μ s,T=1sec)	bias			-
Pulse life test cycle=0.125 (tp=125 μ s,T=1sec)		10/1/40/0		
	Dulas life toot	10/ 1/ 40/ 0		
l Duration 500nrs)	Puise life test			
		10/1/70/0	1505 4404 4	
		1Q/ 1/ 76/ 0		A cycle: -40 degree C 15min; +85 degree C
Temperature IEC 68-2-14, Nb 15min	Temperature		IEC 68-2-14, Nb	_
lavala				
300 cycles	oyolo .			
2 chamber/ Air-to-air type				
High humidity 1Q/ 1/ 40/ 0 CNS-6117 60+3°C		1Q/ 1/ 40/ 0	CNS-6117	
storage test 90+5/-10% R.H. for 500hrs				
High temperature 1Q/ 1/ 40/ 0 CNS-554 100+10°C for 500hrs	High temperature	1Q/ 1/ 40/ 0	CNS-554	100+10°C for 500hrs
storage test				
Low temperature 1Q/ 1/ 40/ 0 CNS-6118 -40+5°C for 500hrs		1Q/ 1/ 40/ 0	CNS-6118	-40+5°C for 500hrs
storage test				



IN-S126TASRGB Side View SMD LED 1206 PCB Type

Revision History

Changes since last revision	Page	Version No.	Revision Date
Initial Release		1.0	05-12-2017
Updated	P1	1.1	09-30-2020

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